

## **Search Notes**



**Application/Control No.**

10/041,849

**Examiner**

Patrick H. Mackey

**Applicant(s)/Patent under  
Reexamination**

TENG ET AL.

## **Art Unit**

3651

SEARCHED			
Class	Subclass	Date	Examiner
414	403 416.01 618		
	729 749.3		
	416.03		
	416.08		
901	3-5 9 46-47		
250	559.33		
414	937		
700	218 257	2/11/2005	PHM
Above	Updated	6/24/2005	PHM
Above	Updated	1/6/2006	PHM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner